Notice of References Cited Application/Control No. | Applicant(s)/Patent Under | Reexamination | OGG, STEVEN S. | Examiner | EDMUND H. LEE | 1732 | Page 1 of 1

U.S. PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Name | Classification |
|---|---|--|-----------------|---------------------|----------------|
| | Α | US-6,165,049 | 12-2000 • | Yamaguchi, Takehiko | 451/6 |
| | В | US-6,644,948 | 11-2003 | Mydlack et al. | 425/116 |
| | С | US-2,787,024 | 04-1957 | SMITH ROBERT F | 264/275 |
| | D | US-5,494,631 | 02-1996 | Oka et al. | 264/161 |
| - | E | US-6,248,974 | 06-2001 | Wai, Martin P. | 219/121.69 |
| • | F | US-6,597,445 | 07-2003 | Sugimoto, Kazushige | 356/237.1 |
| | G | US- | | | |
| | Н | US- | | | |
| | ı | US- | | | |
| | J | US- | | | |
| | к | US- | | | |
| | L | US- | | | |
| | М | US- | | | |

FOREIGN PATENT DOCUMENTS

| * | | Document Number Country Code-Number-Kind Code | Date MM-YYYY | Country | Name | Classification |
|---|---|--|-----------------|---------|------|----------------|
| | N | | | | | |
| | 0 | | | | | |
| | Р | | | | | |
| | Q | | | | | |
| | R | | | | | |
| | s | | | | | |
| | Т | | | | | |

NON-PATENT DOCUMENTS

| * | | Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) |
|---|---|---|
| | J | |
| | ٧ | |
| | w | · |
| | x | |

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.